

T-25-09
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Reference No. SA01TY23

DIGITRON

alt
DGE
090086

DGE -05 1500
SCR

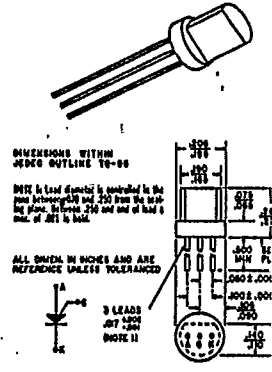
C13

Outstanding Features

- Planar Passivated Structure
- Low Leakage Current
- Low Triggering Current
- Low Forward Voltage Drop
- Low Cost
- High Gate Breakdown Voltage

Applications

- Automotive Switching
- SCR Triggering
- Ring Counters
- Level Detectors
- Fuse Circuits
- Miniature Lamp Drivers
- Low Level Logic
- Memory Circuits



The C13 GSCR operates similarly to the conventional SCR. The major difference is that the device is turned on by forward bias the junction between the anode and the anode gate. The voltage on the anode gate is made negative with respect to the voltage of anode. "Conventional" SCR's are turned on by injecting current into the lower p-base (cathode gate), while those that are tu on through the upper n-base (anode gate) are called "complementary" SCR's. A four-terminal, Silicon Controlled Switch (SCS) connections to both bases and either, or both, bases may be used to initiate switching.

MAXIMUM ALLOWABLE RATINGS

Type	Peak Forward Blocking Voltage, V_{BVM} ($R_{GK} = 1K$)	Working and Repetitive Peak Reverse Voltage, V_{RWM} & V_{RSM} (Open Gate)	Non-Repetitive Peak Reverse Voltage, V_{RSM} (Open Gate)
C13Y	80 volts	80 volts	80 volts
C13F	50 volts	50 volts	50 volts

- *Reverse Blocking Voltage, V_{BR} (Finite gate resistance) 5 V
- Continuous Forward Current, I_{FM} 250 Milliam
- Peak Forward Current, I_{FPM} (10 μ sec., 1% Duty Cycle, 100°C) 8 Am
- Peak Forward Current, I_{FPM} (100 μ sec., 1% Duty Cycle, 100°C) 1 Am
- Peak Forward Surge Current, I_{FSM} (non-repetitive, 5 μ sec., 25°C) 10 Am
- Peak Forward Gate Current, I_{GM} 50 Milliam
- Peak Reverse Gate Current, I_{GR} 50 Milliam
- Peak Reverse Gate Voltage, V_{GR} 80 V
- Average Gate Power Dissipation, P_{GAV} 10 Milli
- Storage Temperature, T_{STG} -55°C to +1
- Operating Temperature -55°C to +1
- Total Power, P_T (Derate linearly to 0 at 100°C) 450

*When used on AC operation with finite gate resistance, a diode must be added in series with the cathode to absorb the reverse voltage.

CHARACTERISTICS (at 25°C, unless otherwise noted)

Test	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Forward Blocking Current	I_D	—	.01	0.10	μ A	$V_D = \text{rated}, R_G = 1K$
			0.10	100		$V_D = \text{rated}, R_G = 1K, T_A = 100^\circ C$
Reverse Blocking Current	I_R	—	.001	0.10	μ A	$V_R = \text{rated}, \text{Open Gate}$
			.10	100		$V_R = \text{rated}, \text{Open Gate}, T_A = 100^\circ C$
Gate Trigger Current*	I_{GT}	—	.05	—	μ A	$V_D = 6 \text{ volts}, R_L = 100 \text{ ohms}$
			2.0	20		$V_D = 6 \text{ volts}, R_L = 100 \text{ ohms}, T_A = -55^\circ C$
Gate Trigger Voltage**	V_{GT}	—	0.45	0.80	Volts	$V_D = 6 \text{ volts}, R_L = 100 \text{ ohms}$
			0.25	0.40		$V_D = 6 \text{ volts}, R_L = 100 \text{ ohms}, T_A = 100^\circ C$
Forward Voltage Drop	V_F	—	1.4	1.8	Volts	$I_F = 250 \text{ mA}$
			1.4	—		$I_F = 250 \text{ mA}, T_A = 100^\circ C$
Holding Current	I_H	—	0.70	—	mA	$R_G = 1K$
			0.42	—		$R_G = 1K, T_A = 100^\circ C$
Turn-On Time	t_{on}	—	—	0.10	μ sec	see Circuit A
Recovery Time	t_{re}	—	—	10	μ sec	see Circuit B

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